

Notice of References Cited	Application/Control No. 10/708,697	Applicant(s)/Patent Under Reexamination COSTA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0173370 A1	11-2002	Chapman, Christopher Ray	473/258
	B	US-2003/0027657 A1	02-2003	Yamada, Megumi	473/265
	C	US-389,336	09-1888	STUNDEN, JESSE	211/198
	D	US-1,637,339	08-1927	GLENNON MICHAEL J; et. al.	473/265
	E	US-3,482,838	12-1969	GIBSON SIDNEY H; et. al.	473/264
	F	US-3,753,563	08-1973	Previte, Jr., John R.	473/265
	G	US-4,261,469	04-1981	Stone, Frederick K.	211/119.1
	H	US-4,869,510	09-1989	Battersby, Gary	473/264
	I	US-5,776,007	07-1998	Kendall et al.	473/258
	J	US-6,048,273 A	04-2000	Clement, Clint D.	473/261
	K	US-6,755,751 B2	06-2004	Chapman, Christopher Ray	473/229
	L	US-6,695,710 B2	02-2004	Yamada, Megumi	473/265
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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